

AUIRLR014N

HEXFET<sup>®</sup> Power MOSFET

55V

#### Features

- Advanced Planar Technology
- Logic Level Gate Drive
- Low On-Resistance
- Dynamic dV/dT Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

#### Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.

	R <sub>DS(on)</sub>	max.	0.14Ω
S	I <sub>D</sub>		10A
		D	

V<sub>DSS</sub>



G	D	S
Gate	Drain	Source

Bass nort number	Deekege Ture	Standard Pack		Ordereble Port Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRLR014N		Tube	75	AUIRLR014N
AUIKLRU14N	D-Pak	Tape and Reel Left	3000	AUIRLR014NTRL

#### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	10	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	7.1	А
I <sub>DM</sub>	Pulsed Drain Current ①	40	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	28	W
	Linear Derating Factor	0.2	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 16	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) ②	35	mJ
I <sub>AR</sub>	Avalanche Current ①	6.0	A
E <sub>AR</sub>	Repetitive Avalanche Energy ①	2.8	mJ
dv/dt	Peak Diode Recovery3	5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

#### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case 6		5.3	
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount) 🗇		50	°C/W
$R_{ ext{ heta}JA}$	Junction-to-Ambient		110	

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\*Qualification standards can be found at www.infineon.com



# AUIRLR014N

#### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	55			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.056		V/°C	Reference to 25°C, $I_D$ = 1mA
				0.14		V <sub>GS</sub> = 10V, I <sub>D</sub> = 6.0A ④
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.21	Ω	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 5.0A ④
/ <sub>GS(th)</sub>	Gate Threshold Voltage	1.0		3.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Jfs	Forward Trans conductance	3.1			S	V <sub>DS</sub> = 25V, I <sub>D</sub> = 6.0A
	Drain-to-Source Leakage Current			25		V <sub>DS</sub> = 55V, V <sub>GS</sub> = 0V
DSS				250	μA	V <sub>DS</sub> = 55V,V <sub>GS</sub> = 0V,T <sub>J</sub> =150°C
	Gate-to-Source Forward Leakage			100	<b>n</b> A	V <sub>GS</sub> = 16V
GSS	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = - 16V

## Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Q <sub>g</sub>	Total Gate Charge			7.9		I <sub>D</sub> = 6.0A
Q <sub>gs</sub>	Gate-to-Source Charge			1.4	nC	$V_{DS} = 44V$
Q <sub>gd</sub>	Gate-to-Drain Charge			4.4		V <sub>GS</sub> = 5.0V, See Fig. 6 &13 ④
t <sub>d(on)</sub>	Turn-On Delay Time		6.5			$V_{DD} = 28V$
t <sub>r</sub>	Rise Time		47			I <sub>D</sub> = 6.0A
t <sub>d(off)</sub>	Turn-Off Delay Time		12		ns	$R_{G} = 6.2\Omega, V_{GS} = 5.0V$
t <sub>f</sub>	Fall Time		23			R <sub>D</sub> = 4.5Ω,See Fig. 10④
L <sub>D</sub>	Internal Drain Inductance		4.5		лЦ	Between lead, 6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5			from package
C <sub>iss</sub>	Input Capacitance		265			V <sub>GS</sub> = 0V
Coss	Output Capacitance		80		pF	V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		38			<i>f</i> = 1.0MHz, See Fig.5
Diode Cha	racteristics					
	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current (Body Diode)			10		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			40		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 6.0A, V_{GS} = 0V$ (4)
t <sub>rr</sub>	Reverse Recovery Time		37	56	ns	T <sub>J</sub> = 25°C ,I <sub>F</sub> = 6.0A
Q <sub>rr</sub>	Reverse Recovery Charge		48	71	nC	di/dt = 100A/µs④
t <sub>on</sub>	Forward Turn-On Time	Intrinsic	turn-or	n time is	negligil	ble (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

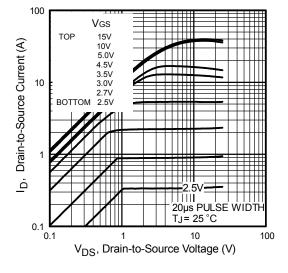
 $\odot$  Starting T<sub>J</sub> = 25°C, L = 1.96mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = 6A (See fig. 12)

④ Pulse width  $\leq$  300µs; duty cycle  $\leq$  2%.

⑤ This is applied for I-PAK, L<sub>S</sub> of D-PAK is measured between lead and center of die contact.

6 When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994





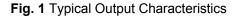


Fig. 2 Typical Output Characteristics

V<sub>DS</sub>, Drain-to-Source Voltage (V)

1111

10

20µs PULSE WIDTH TJ= 175 °C

100

100

10

0.1 **Ľ** 0.1

ID, Drain-to-Source Current (A)

TOP

воттом

Vgs

15V 10V 5.0V 4.5V 3.5V 3.5V 2.7V 2.7V 2.5V

1

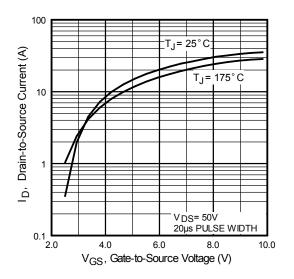


Fig. 3 Typical Transfer Characteristics

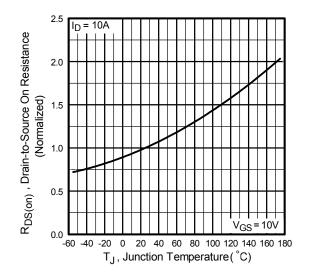
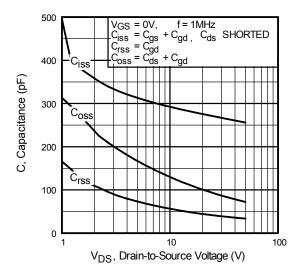


Fig. 4 Normalized On-Resistance Vs. Temperature







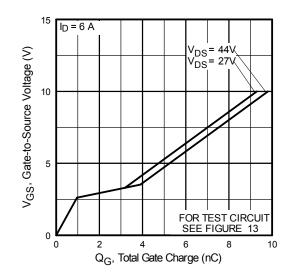
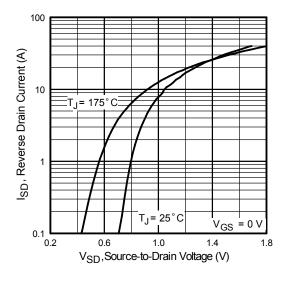
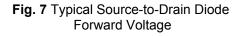


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage





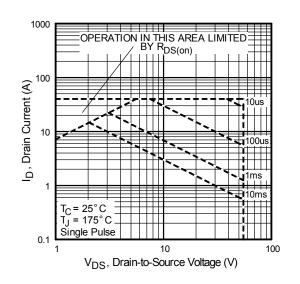
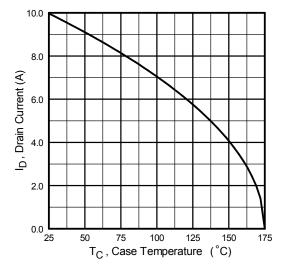


Fig 8. Maximum Safe Operating Area







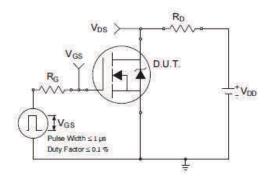


Fig 10a. Switching Time Test Circuit

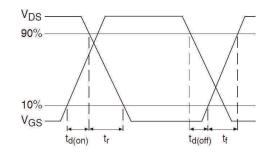


Fig 10b. Switching Time Waveforms

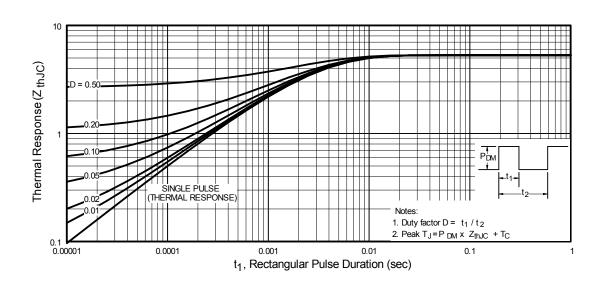


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

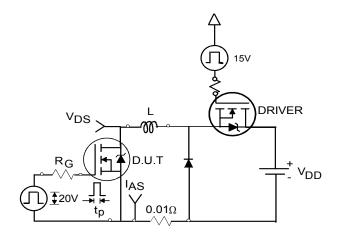


Fig 12a. Unclamped Inductive Test Circuit

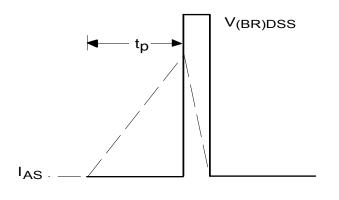


Fig 12b. Unclamped Inductive Waveforms

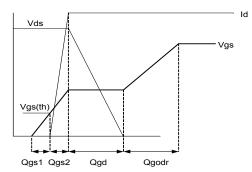
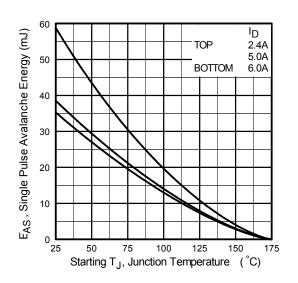
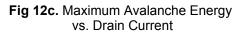


Fig 13a. Gate Charge Waveform





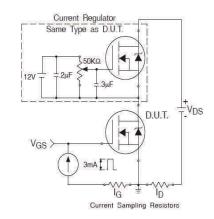
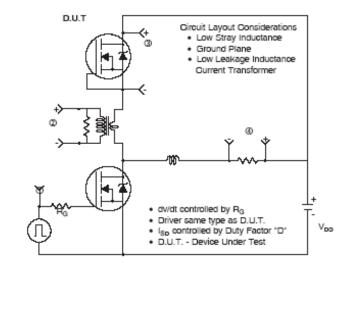
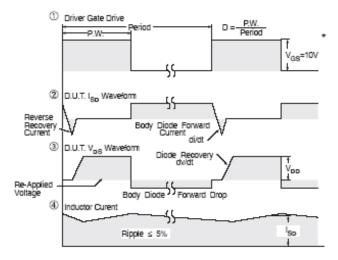


Fig 13b. Gate Charge Test Circuit





# Peak Diode Recovery dv/dt Test Circuit



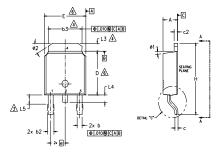
 $^{*}$  V<sub>GS</sub> = 5V for Logic Level Devices



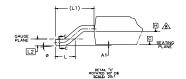


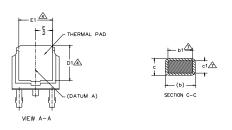
# AUIRLR014N

## D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].

A- LEAD DIMENSION UNCONTROLLED IN L5.

- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.

 $\underline{\&}$  - DATUM A & B TO BE DETERMINED AT DATUM PLANE H. 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S Y M		DIMEN	SIONS		N
В	MILLIM	ETERS	INC	HES	0 T E S
0 L	MIN.	MAX.	MIN.	MAX.	E S
Α	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
ь1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
с	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Е	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
е	2.29	BSC	.090	BSC	
н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
ø	0.	10 <b>°</b>	0.	10*	
ø1	0.	15 <b>°</b>	0.	15°	
ø2	25'	35*	25*	35*	

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

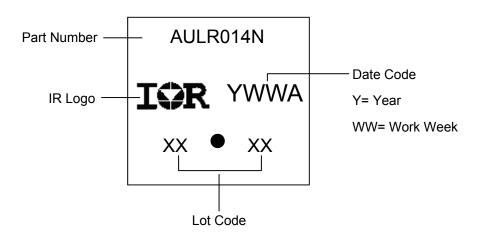
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

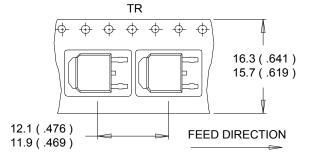
4.- COLLECTOR

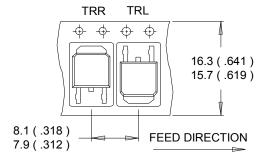
# D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

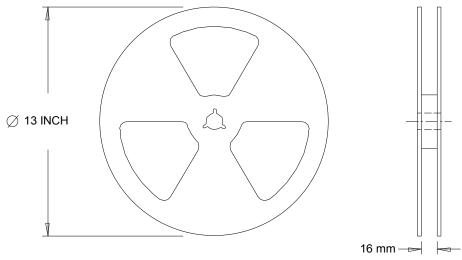
## D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





#### NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



# NOTES :

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



#### **Qualification Information**

			Automotive (per AEC-Q101)		
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture Sensitivity Level		D-Pak	MSL1		
		Class M1B (+/- 75V) <sup>†</sup>			
	Machine Model	AEC-Q101-002			
	Liver on Dady Madel	Class H1A (+/- 300V) <sup>†</sup>			
ESD	Human Body Model	AEC-Q101-001			
		Class C5 (+/- 2000V) <sup>†</sup>			
	Charged Device Model	AEC-Q101-005			
RoHS Compliant			Yes		

+ Highest passing voltage.

#### **Revision History**

Date	Comments		
12/11/2015	Updated datasheet with corporate template		
12/11/2015	Corrected ordering table on page 1.		

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